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PATENT
ATTORNEY DOCKET NO. 0075/021001

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Detlef KNEBEL et al. Art Unit: 2881
Application No.: 10/521,563 Examiner: Logie, M.
Title: METHOD FOR LOCALLY HIGHLY RESOLVED, MASS-SPECTROSCOPIC
CHARACTERIZATION OF SURFACES USING SCANNING PROBE
TECHNOLOGY

International Application No.: PCT/DE2003/002493
International Filing Date : July 24, 2003
Priority Date : July 24, 2002
U.S. Filing Date : January 19, 2005

Mail Stop Amendment

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

TRANSMITTAL LETTER

Sir:

In response to the Office Action dated August 10, 2007, applicants hereby submit the enclosed papers including an Amendment under 37 CFR 1.111. Since November 10, 2007 is a Saturday and November 11, 2007 is a Sunday and November 12, 2007 is a National Holiday, applicants believe that this is a timely response within the shortened statutory period and that no extension of time fees are required.

The required fees are calculated below:

Total Claims	<u>22</u>	-	<u>20</u>	=	<u>2</u>	\$50.00
Independent	<u>4</u>	-	<u>3</u>	=	<u>1</u>	\$105.00

TOTAL FEE DUE: \$155.00

11/16/2007 GFREY1 00000123 10521563

01 FC:2615 50.00 0P
02 FC:2614 105.00 0P

Transmittal Letter
Application No.: 10/521,563
November 13, 2007

THE COMMISSIONER IS AUTHORIZED TO CHARGE THIS FEE AND ANY OTHER FEES WHICH MAY BE REQUIRED OR CREDIT ANY OVERPAYMENT TO THE CREDIT CARD NUMBER LISTED ON THE ATTACHED CREDIT CARD PAYMENT FORM (PTO-2038 FORM), REFERENCING ATTORNEY DOCKET NO. 0075/021001. A DUPLICATE COPY OF THIS PAPER IS ENCLOSED. THIS IS A GENERAL AUTHORIZATION EXCLUDING ONLY PAYMENT OF THE ISSUE FEE.

Respectfully submitted,


Randolph A. Smith
Reg. No. 32,548

Date: November 13, 2007

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AMENDMENT UNDER 37 CFR 1.111

Sir:

In response to the Office Action dated August 10, 2007,
please amend the application as follows:

Amendments to the Claims begin on page 2 of this paper.

Remarks begin on page 9 of this paper.